GR3281 Page 1 of 2

**GR3281**.....23rd April 1999



## **DESCRIPTION**

The GR3281 is a 32768 word by 8 bits (32K x 8) non-volatile CMOS Static Ram, fabricated from advanced silicon gate CMOS technology and a high reliability lithium power cell. The pin-out of the GR3281 conforms to the JEDEC standards and is fully compatible with normal static RAM. The power down circuit is fully automatic and is referenced at 4.5 volts. At this point the GR3281 is write protected by an internal inhibit function for Data Protection and the memory contents are retained by the lithium power source. Power down is very fast, this being essential for data integrity, taking a maximum of 15  $\mu$ S (15 microseconds) to power down from 5 volts to 0 volts. This is much faster than system power failure conditions. Therefore there are no special conditions required when installing the GR3281. The GR3281 can, without external power, retain data almost indefinitely. The limiting factor will be the shelf life of the lithium cell, which is typically ten years. It is possible that this figure may be extended in view of the extremely light duty imposed upon the cell.

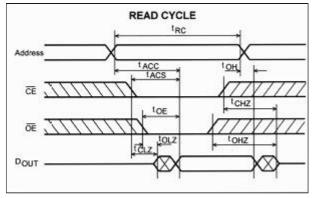
## **TECHNICAL DATA**

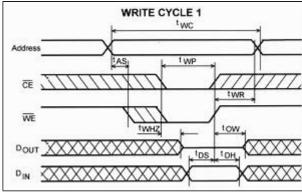
A	BSOLUTE MAX	KIMUM RATINGS	
Symbol	Min	Max	Units
Vdd	- 0.3	7.0	Volts
Vi/o	-0.3	Vdd + 0.3	Volts
Temp	- 20	+70	deg. C

1000	10,000	OPER	RATING MC	DE	
CE	OE	WR	MODE	OUTPUT	ldd
H	X	X	Unsel.	Hi-Z	Deselected
L	н	H	Unsel.	Hi-Z	Active
L	L	н	Read	Dout	Active
L	X	L	Write	Din	Active

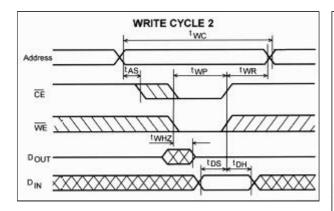
A14 A12 A7	2 3	28 27 26	Vdd WR A13	PIN DE	SIGNATIONS
A6	4	25	A8	Pin	Function
A5	5	24	A9	A0-A12	Address I/P's
A4	6	23	A11	Jan 19 19 19 19 19 19 19 19 19 19 19 19 19	
A3	7	22	A11 OE	D0-D7	Data in/out
A2	8-	21	A10 CE	ŌĒ	Output Enable
A1.	91	20	CE	CE	Chip Enable
A0	10	19	D7	- minimum -	
D0	11	18	D6	WR	Write Enable
D1	12	17	D5	Vdd	+5Volt Power
D2	13	16	D4	GND	Ground
GND	11	15	D3	GND	Giouna

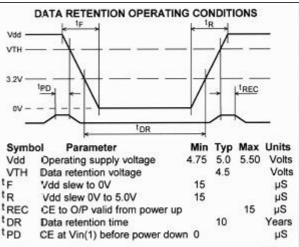
OPER	RATING (	CONDITI	ONS	
Symbol	Min	Тур	Max	Unit
Vdd	4.75	5.0	5.5	Volts
Vin (1)	2.2			Volts
Vin (0)			0.8	Volts
lin (any other pin)	- 1.0		+1.0	μA.
Vout $(1)(lout = -1mA)$	2.4			Volts
Vout $(0)(lout = +2mA)$			0.4	Volts
Idd (Active)		30		mA.
Idd (Deselected)		1.0		mA.
Tcycle			100	nS.
Cin (any pin)		10		pF



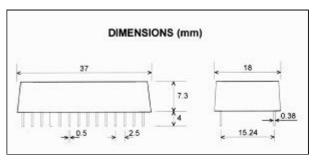


GR3281 Page 2 of 2





	Read Cycle	100nS		
Symbol	Parameter	Min	Max	
<sup>t</sup> RC	Read cycle time	100		
TACC	Access time		100	
TACS	CE to output valid		100	
OE	OE to output valid		50	
CLZ	CE to output active	10		
OLZ	OE to output active	10		
HO	Output hold time	20		
CHZ	CE to output disable		35	
<sup>t</sup> OHZ	OE to output disable		35	
	Write Cycle	100nS		
Symbol	Parameter	Min	Max	
twc:	Write cycle time	100		
t <sub>WP</sub>	Write pulse width	60		
<sup>t</sup> AS	Address setup time	0		
twr:	Write recovery time	0		
<sup>t</sup> WHZ	WR to output disable		35	
WO	Output active from WR	10		
t DS	Data setup time	35		
<sup>t</sup> DH	Data HOLD TIME	0		
otes	. b b			
	e high during address transit urs during the overlap of a lo			



## **APPLICATION**

When powered down, the GR3281 is transportable and data can be moved from system to system, this makes it ideal for program development, data collection in data loggers, program changes in process control, automation and robotics and user definable lookup tables, etc.

Additional information available through our technical sevices department.

